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LEADER


Technology Innovator

LEADER NEWS

HD WORLD Show in New York

Leader Instruments showcased a number of new products and product enhancements during NYC's HD World (held from Oct. 14th to Oct 15th in NYC).

We introduced a number of enhancements for our flagship [HD/SD-SDI test platform, the LV5800](#), including improvements on our already popular AFD functions, as well as several enhancements in the way we detect, display and log ANC data information. In addition, we showed our new and [innovative Phabrix SxE](#) – the first instrument in our industry to handle 3G, HD and SD-SDI inclusive of monitoring, generation and, as of late, a 3G eye pattern – all in a portable, battery powered instrument!

Our production centric test monitors, [LV5330](#), [LV7330](#) and [LV5380](#), grabbed the attention of a number of creative specialists with our new “visual”, easy to understand [CINELITE](#), [CINEZONE](#) and [5-bar](#) features.

Call us for details on these and many other exciting instruments at 1 (800) 645-5104 or see us at www.LeaderUSA.com



[Leader Booth]



[LV5380]



[Hall View]